



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

James M. KRONROD

Art Unit: 2858

Application No.: 10/805,232

Examiner: Amy He

Filed: March 22, 2004

Attorney Dkt. No.: 58268.00369

For: SYSTEM AND METHOD FOR MEASURING THE THICKNESS OR
TEMPERATURE OF A CIRCUIT IN A PRINTED CIRCUIT

RESPONSE UNDER 37 CFR § 1.111

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

August 18, 2005

Sir:

In response to the Office Action dated May 26, 2005, please amend the above-identified application as set forth below.

Amendments to the specification are submitted on page 2.

Amendments to the claims are submitted on page 3.

Remarks are submitted on page 22.